Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/629,808	KATAYAMA ET AL.	
Examiner	Art Unit	
TRONG PHAN	2827	

SEARCHED					
Class	Subclass	Date	Examiner		
365	200	5/23/2007	TP		
·	225.7				
	230.03				
	185.09				
	185.11				
•	185.29				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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